### TECHNICAL PRODUCT INFORMATION



### Microstrip® IV

#### **Product Description**

Microstrip® IV is a negative photoresist stripper with improved EHS properties over conventional chlorinated or phenolic products. Microstrip® IV is an aromatic solvent based stripper with low naphthalene content (typical < 0.5%), designed to provide maximum cleaning efficacy for polyisoprene based negative photoresist.

Microstrip® IV can be used to remove (cross-linked) negative photoresist from traditional integration metals and dielectrics. The chemistry is compatible with silicon, silicon dioxide, silicon nitride, titanium, tungsten, aluminum and its alloys and various other metal substrates.

#### **Recommended Process**

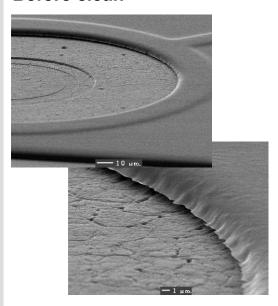
Typical strip conditions are 10-30 min at 75°C to 100°C in Microstrip® IV. Because of the very low solubility of the stripping chemistry in water, intermediate solvent rinses are required. It is recommended to apply at least 2 intermediate rinses with solvents such as cyclopentanone, acetone, n-butylacetate or isopropylalcohol. Process temperatures up to 100°C can be employed to reduce the process time, or to enhance the strip rate on exigent applications.

Microstrip® IV is hygroscopic at temperatures below 75°C and increased water content can lead to elevated metal etch rates. Long term room temperature exposure of Microstrip® IV to air should be avoided.

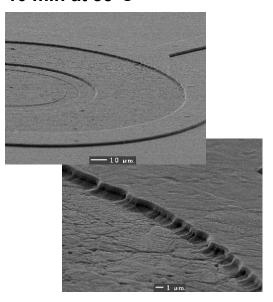
#### Recommended process flow

- 1. Heat two baths of Microstrip<sup>®</sup> IV to 90°C ± 5°C.
- 2. Insert wafers in a carrier and immerse in each bath for 5 to 15 minutes using mild agitation.
- 3. Rinse in cyclopentanone, acetone, n-BA or IPA
- 4. Rinse in IPA
- 5. Rinse in deionized water
- 6. Spin dry

#### Before clean



# After clean with MS IV for 10 min at 85°C



#### **Product Data:**

### Microstrip® IV Metal Etch Rates (85°C)

Metal	Etch Rate (nm/min)
Al	< 0.1
Ni	< 0.1
Au	< 0.1
TiW	< 0.1

Thickness measurements were made using a CDE ResMap 168 four-point probe

### **Physical Properties**

	Microstrip <sup>®</sup> Ⅳ
Specific Gravity @ 15°C	0.987
Flash Point (closed cup)	>100°C
typical value	114°C
Viscosity @ 25°C (cSt)	5.6
Boiling Point	> 200°C
Freezing Point	< 0°C
pH ( 0.1% solution @ 25°C)	< 7

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FCD-1628 Rev 002